



kWh/kWp :
**Comparing modelling, claims and
measurements**

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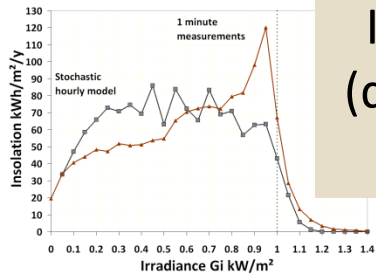
Introduction

- 19 years with BP Solar : indoor and outdoor measurements, modelling and simulation programs
- For the last two years as an independent PV consultant working with clients worldwide
- Studying kWh/kWp on many PV technologies since 1998

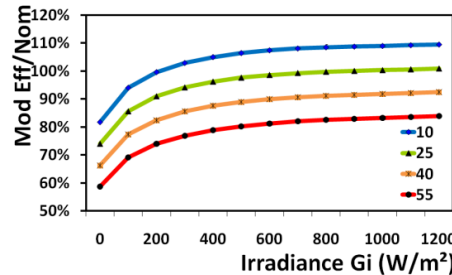
What are the main differences between kWh/kWp simulations and measurements ?

- Some manufacturers have claimed up to 30% higher kWh/kWp than their competitors
- Several recent independent tests show mostly $< \pm 5\%$ between different technologies and manufacturers – dominated by $[P_{\max} \text{ ACTUAL} / P_{\max} \text{ NOMINAL}]$
- Simulation programs often predict $> 5\%$ kWh/kWp difference (usually suggesting better for thin film)
- I have investigated the assumptions made and algorithms used in some simulation programs

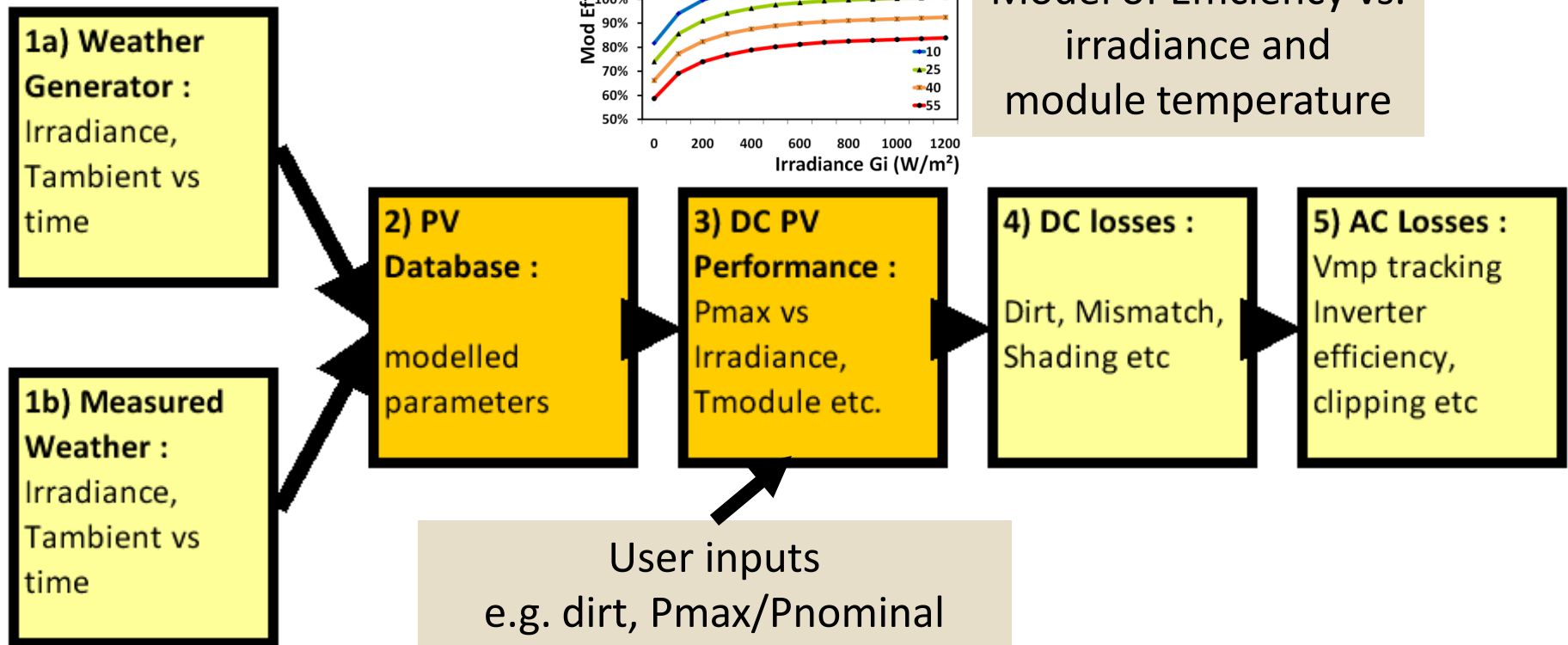
Simulation program flow chart to calculate kWh/kWp



Insolation vs. irradiance
(depends on frequency of
measurement)

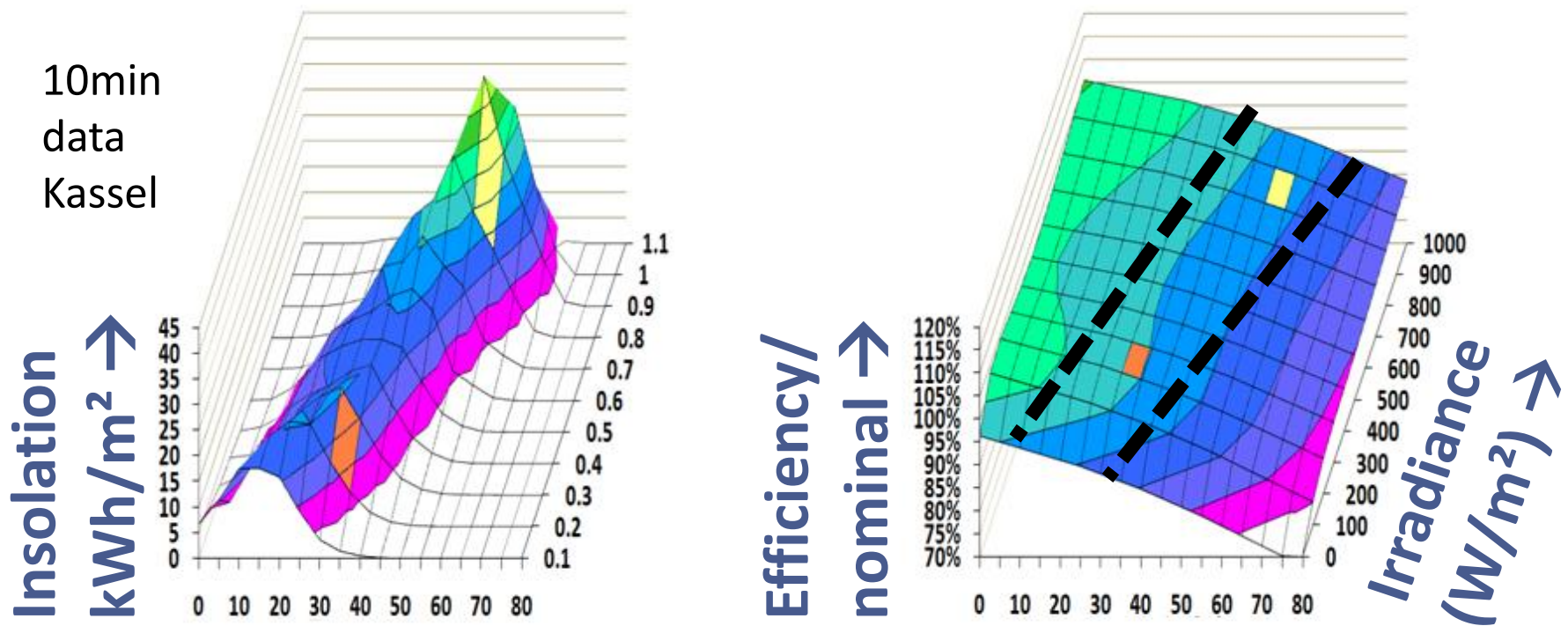


Model of Efficiency vs.
irradiance and
module temperature



How simulation programs usually calculate kWh/kWp (Matrix method)

$$\text{kWh/kWp} \sim \sum \text{Insolation}_{(\text{Tmod}, \text{Irradiance.})} * \text{Efficiency}_{(\text{Tmod}, \text{Irradiance})}$$



Module Temperature (°C)→

A frequent statement :

“My simulation program gives approximate values of kWh/kWp therefore it is validated”

- kWh/kWp depends on the product of >4 items

Insolation
(G_i , T_m)

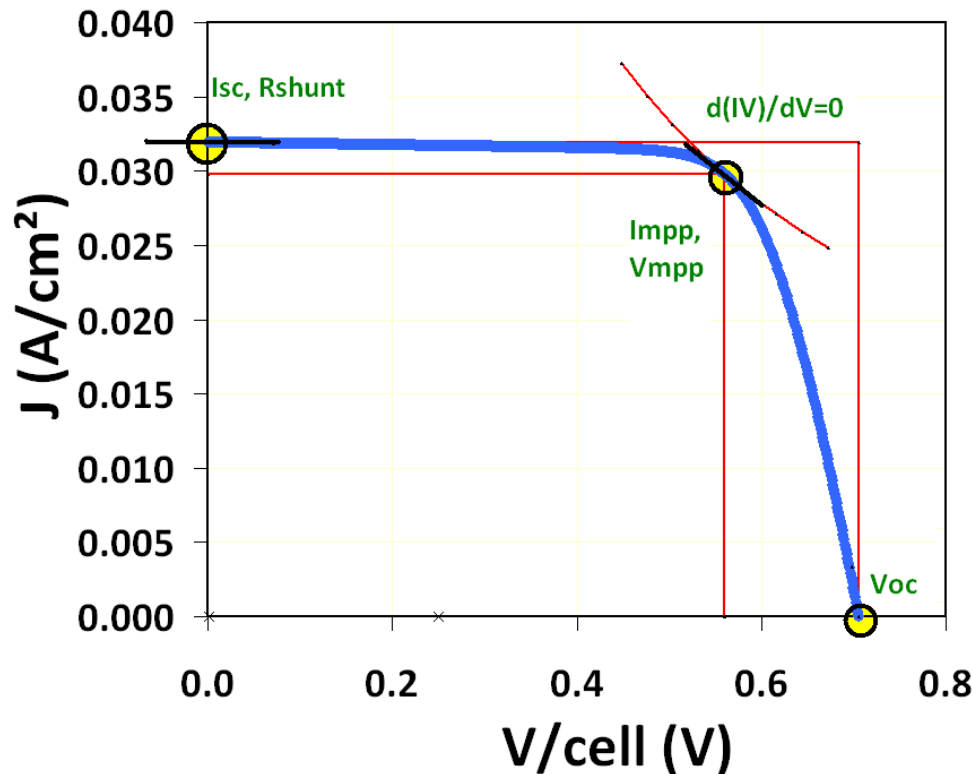
PV Efficiency
(G_i , T_m)

Inverter
Efficiency
(G_i , T_m)

Unknowns
e.g. dirt,
P_{max}/Nominal

- Errors may self cancel (e.g. too high an insolation with too low a PV Efficiency)
- Exact fits to measured data can be found by “fixing” the unknowns – but these would then be technology or site dependent
- Every stage must be checked to be correct to validate a simulation, not just the sum of kWh/kWp

A 1 diode model (de Soto et al) is often used to fit an IV curve to 5 “knowns”



- Usually fitted to manufacturers' data sheets or a tested module
- 1 diode model is not a perfect fit to c-Si or thin film
- Problems fitting c-Si with high R_{sh}
- Diode theory is used to predict temperature dependence (rather than use IEC 61215 / 61646 standard measurements)
- Equation also predicts low light level response (rather than EN 50380 measurements)
- This fits 1 module ,what is the random variability in IV curves?

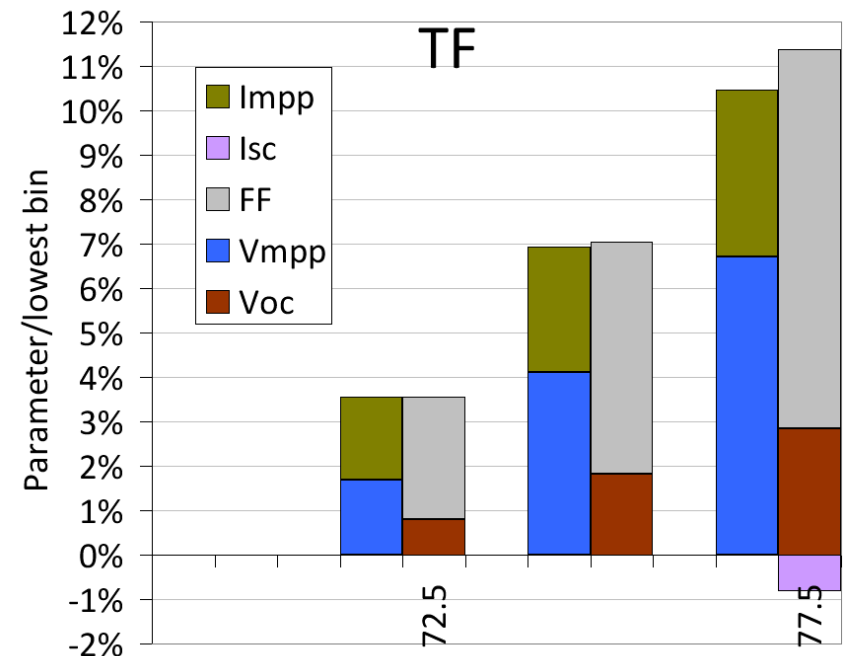
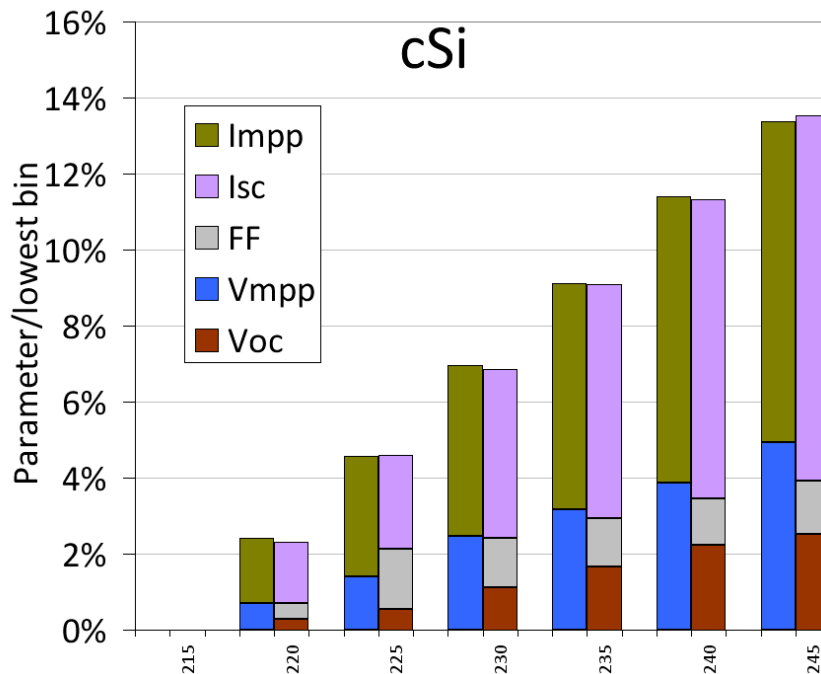
Minimum variation in data sheet module



parameters from for typical c-Si and 1J - Thin Film

(2% bins) More improvements in I_{sc} than V_{oc} or FF

(3% bins) Most improvement in FF, V_{max} (i.e. lower R_{series})



$$P_{max} = I_{mpp} * V_{mpp} ; P_{max} = I_{sc} * V_{oc} * FF$$

kWh/kWp modelling error depends on all the uncertainties in measurements

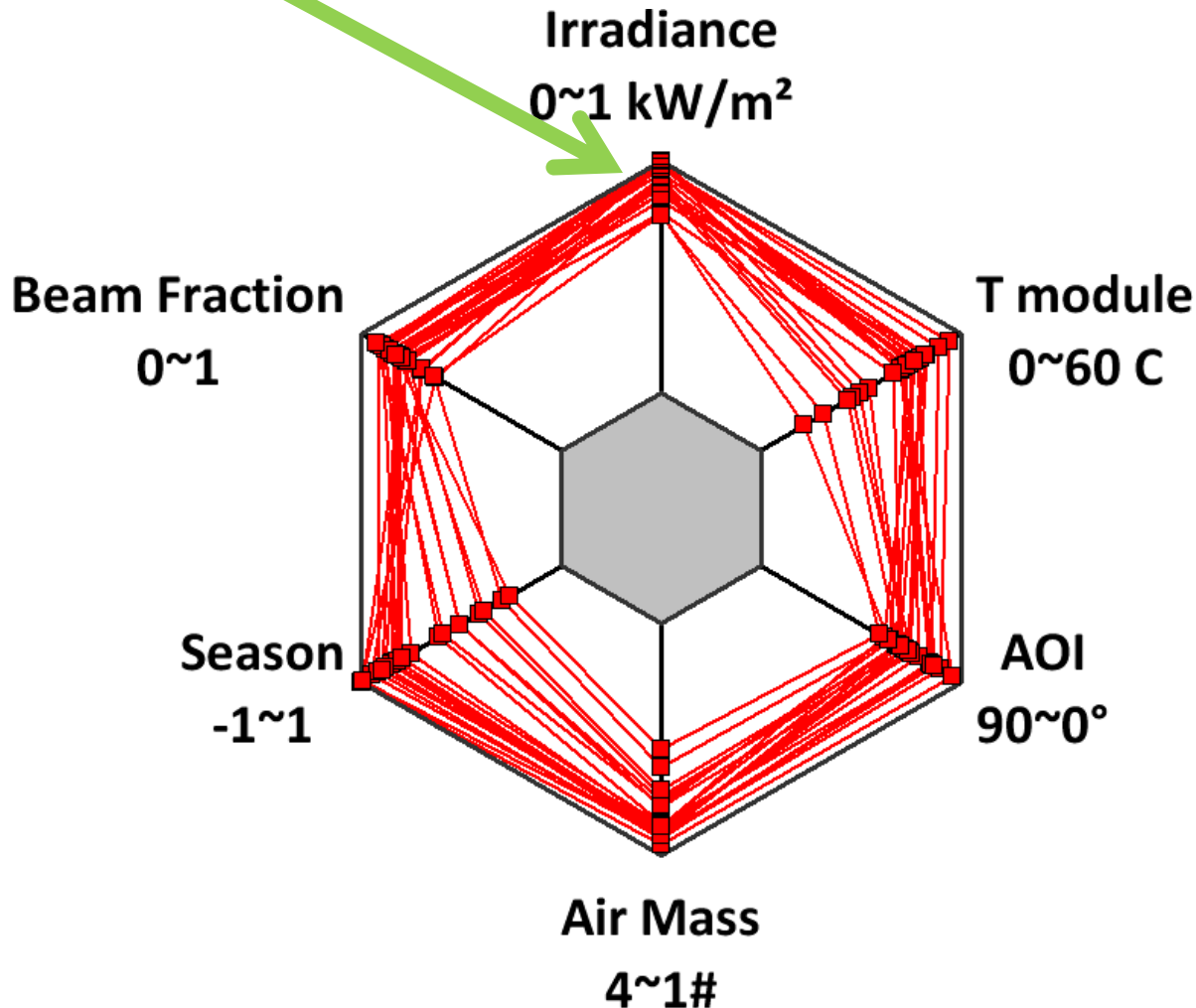
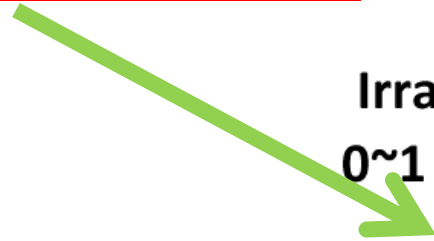


Calibrated reference module Pmax W	>±2.5%	for c-Si, less accurate for thin films
Flash tester W	x% (1%?)	Repeatability error (Not perfect AM1.5 spectrum, capacitance/timing issues)
LID/Pmax degradation allowance %	-1 to -3% -10 to -35%	B doped p type c-Si greater for thin films
Pmax bin width W	~±2.5% ~±2.5%	e.g. 200<Pmax<210W or 100<Pmax<105W
Insolation kWh/m²	~±2-3% ~±1.7-7% ???	pyranometer reference cell Satellite data, Tilted plane algorithm, site interpolation
Module temperature	~3°C/sun ~0.5 to 1.5%	($T_{JUNCTION} - T_{BACK}$) % Pmax error (assuming gamma is -0.15 to -0.5%)
Yearly insolation	~±4%/y	random variations, more effects such as el Niño etc.
Micro climate	?	<u>Can't linearly interpolate</u> near coasts, mountains etc.
Shading loss	?	Varying tree cover, new buildings, self shading
Dirt loss	?	Site dependent daily rise, falls after clean or ~>5mm rain
Snow cover	?	Winter when low daily insolation – small effect ?
Mounting C	?	High temperatures from close mounting, BIPV etc.

Correlation of meteorological parameters



High Irradiance



High Irradiance

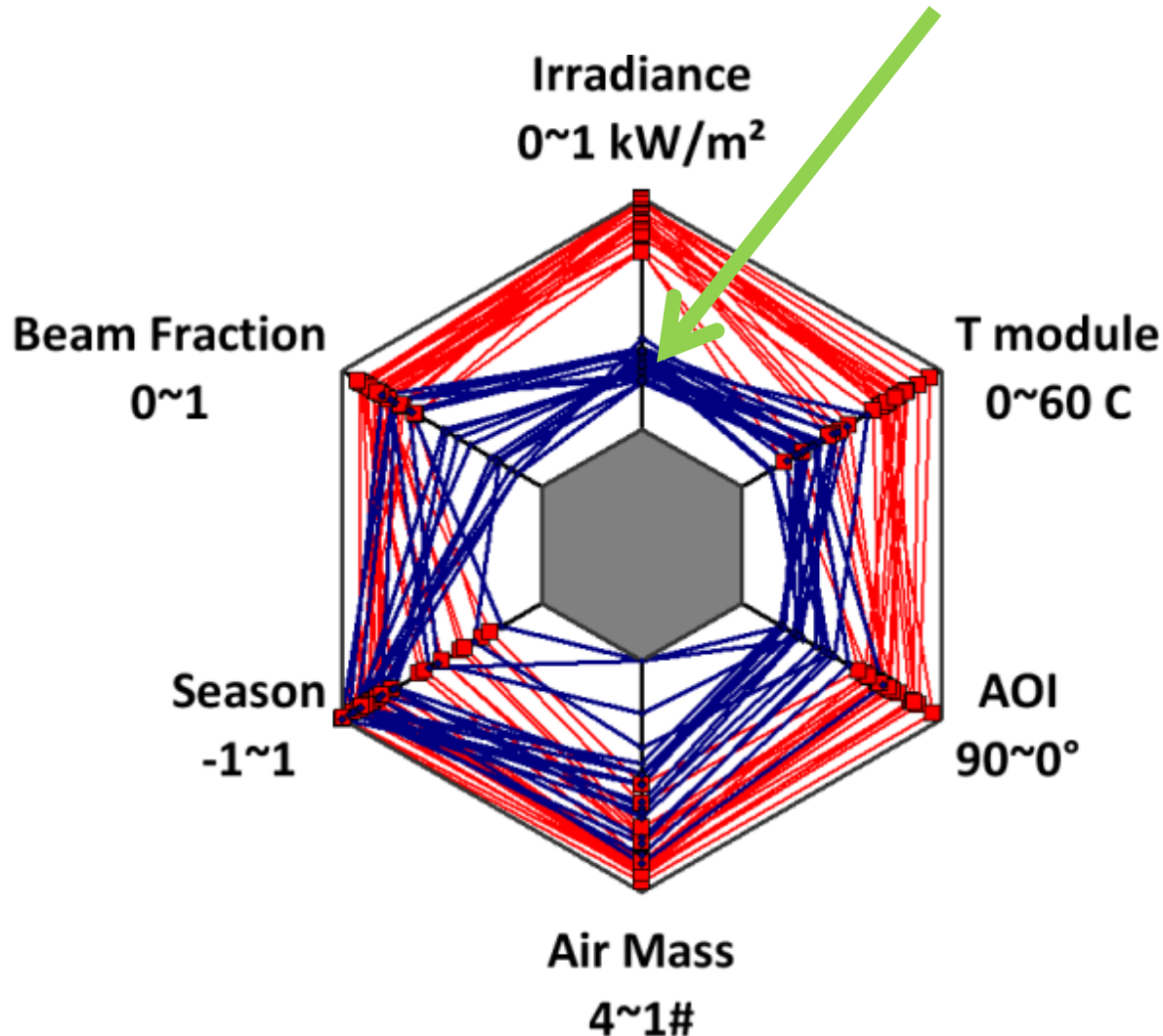
correlates with

- High Temperatures
- Low Angle of incidence
- Low Air Mass
- Summer
- High Beam Fraction

Correlation of meteorological parameters



High Irradiance vs. Low Irradiance



High Irradiance

correlates with

- High Temperatures
- Low Angle of incidence
- Low Air Mass
- Summer
- High Beam Fraction

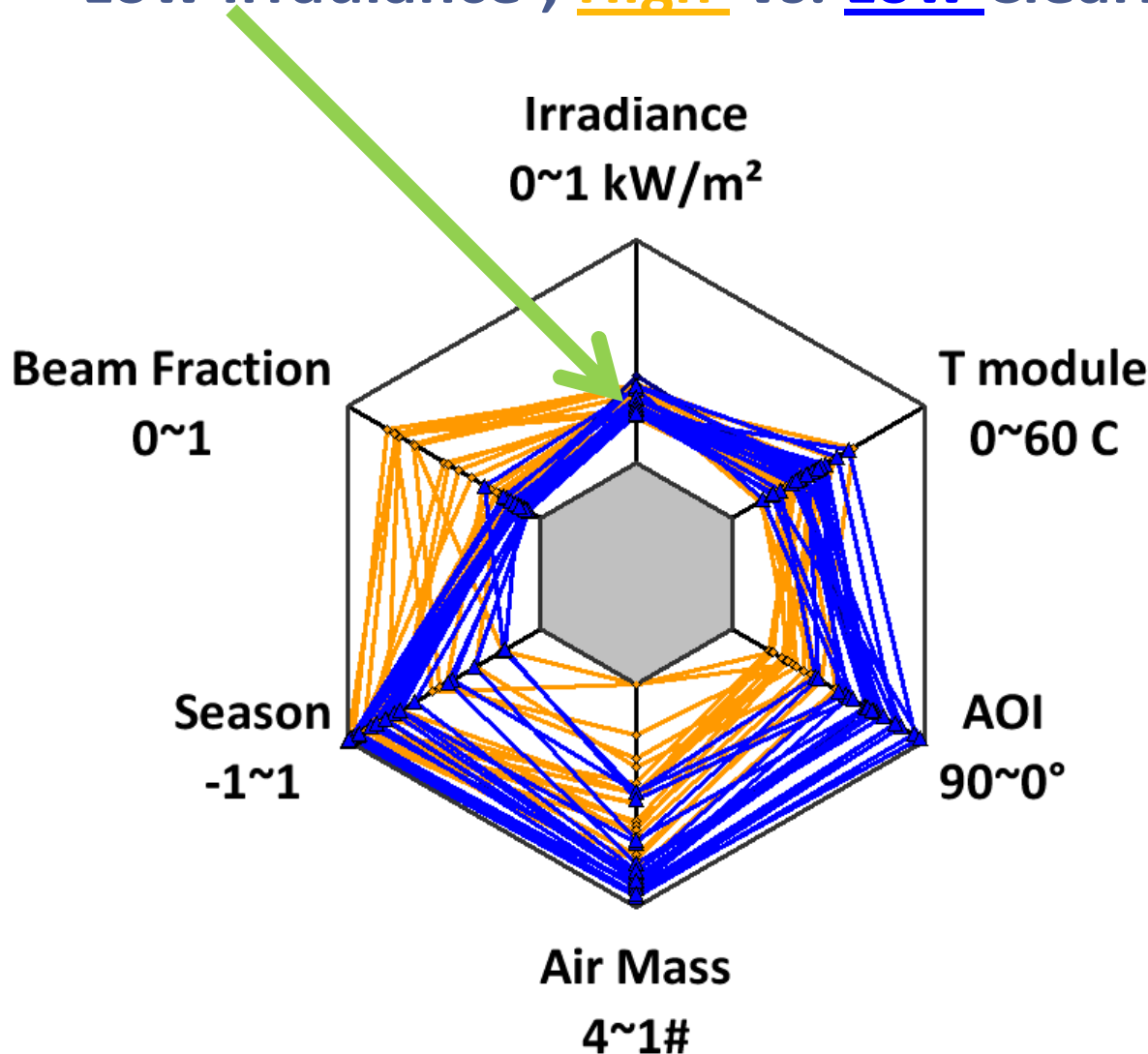
Low Irradiance

correlates with the opposite values

Correlation of meteorological parameters



Low Irradiance ; High vs. Low Clearness



High Clearness

- clear morning/evening
- high angle of incidence, clear sky

Low Clearness

- dull daytime
- Lower angle of incidence and overcast sky

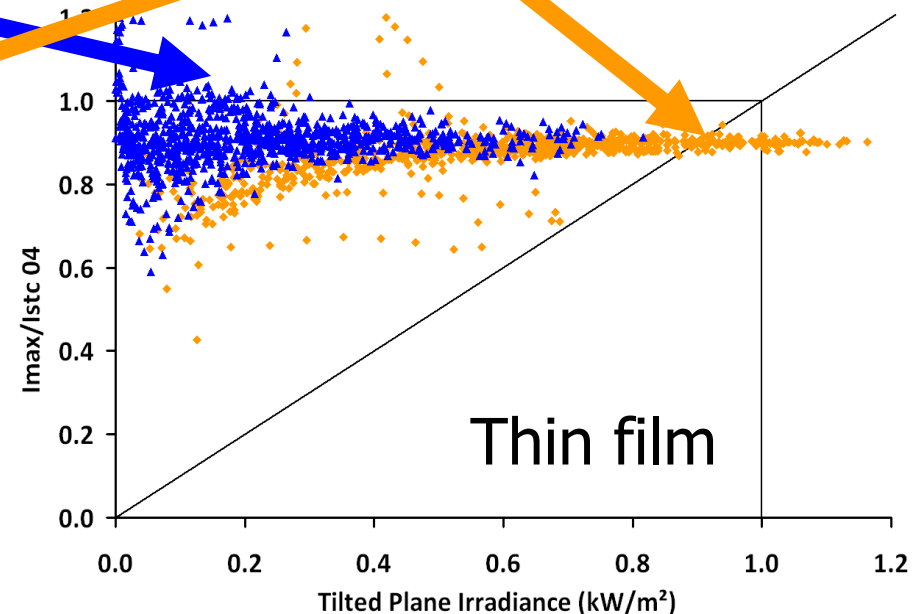
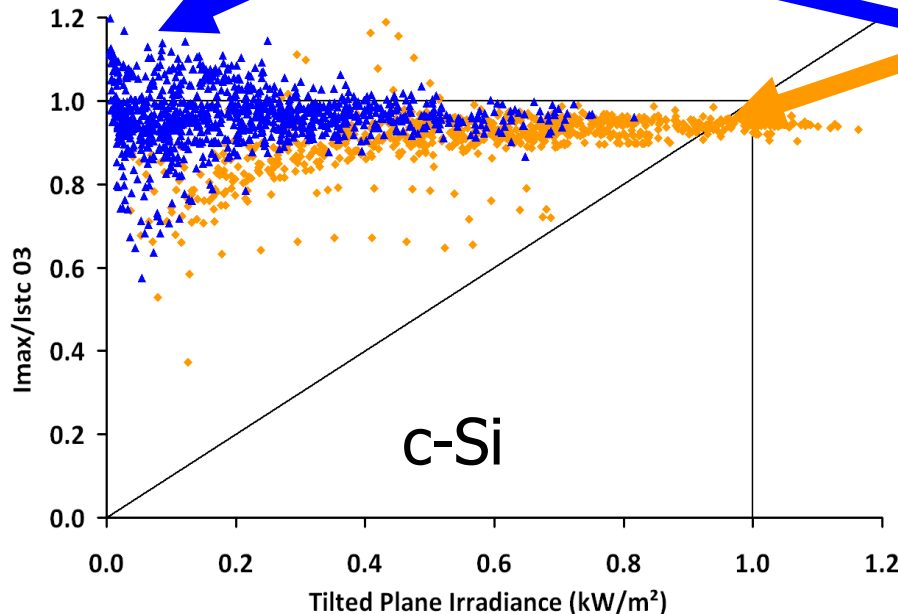
Measured outdoor low light level efficiency will be a site dependent mix of these two conditions

Measured efficiency vs. light level for Low and High clearness conditions (IWES Kassel)



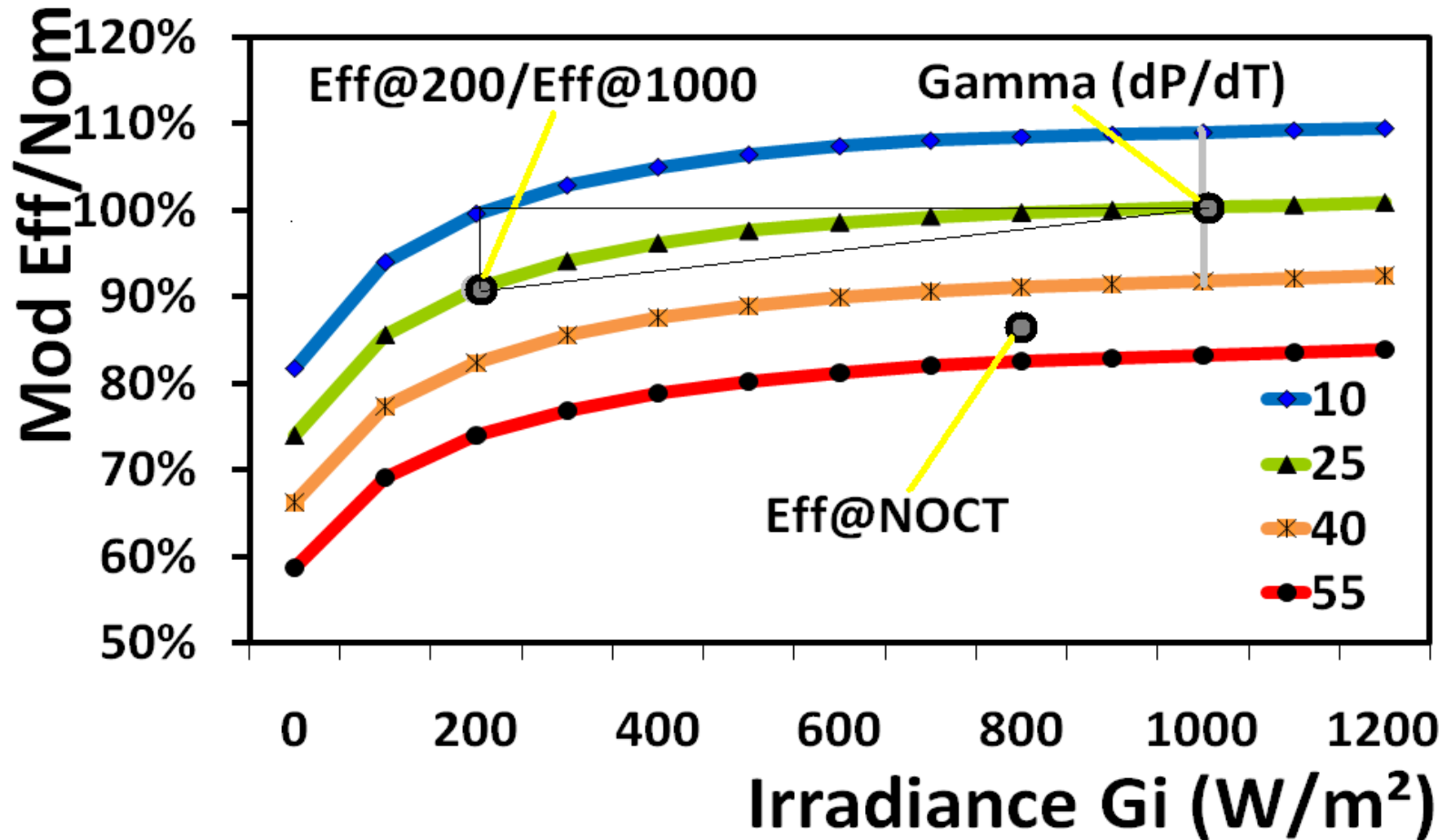
(dull daytime) Scatter and rise in efficiency at low light

(clear mornings/evenings) Fall in efficiency ~ high AOI, Air mass at low light



- Low light value depends on sensor spectral response
- Averaged low light value depends on overcast: clear ratio (site specific)

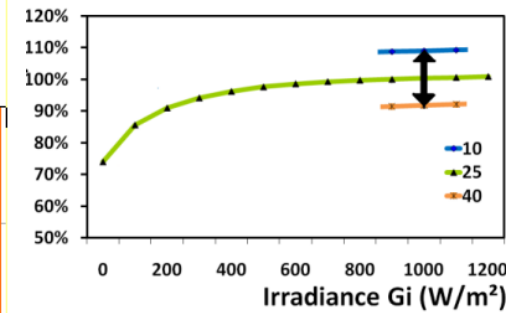
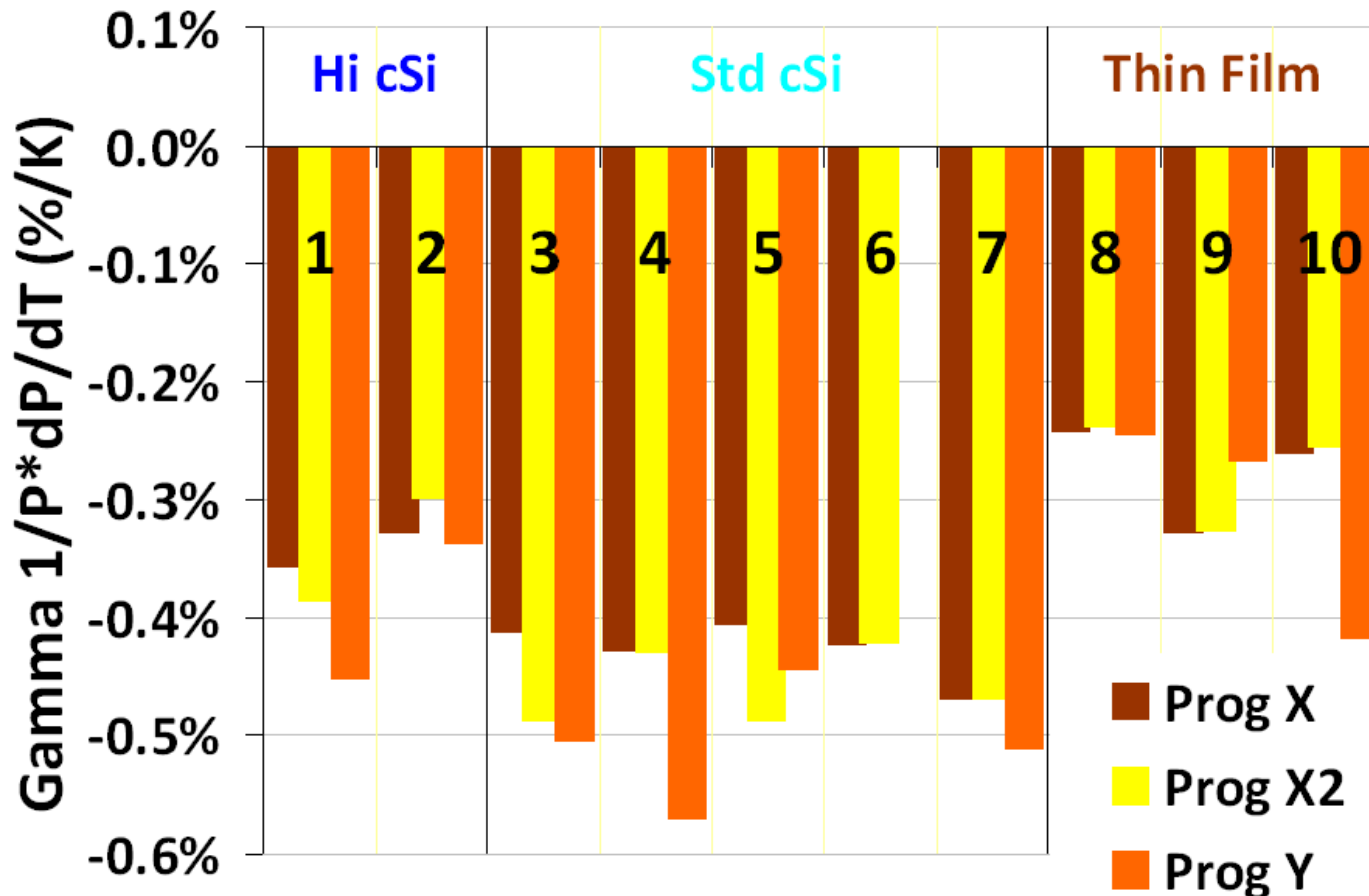
Calculating IEC standard values from PV efficiency/nominal vs. irradiance and module temperature :



Comparing power temperature coefficients ($\text{Gamma} = 1/P_{\text{max}} * dP_{\text{max}}/dT$)



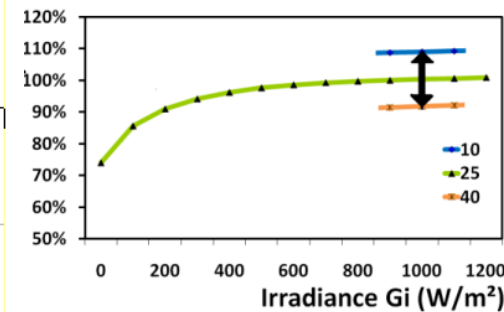
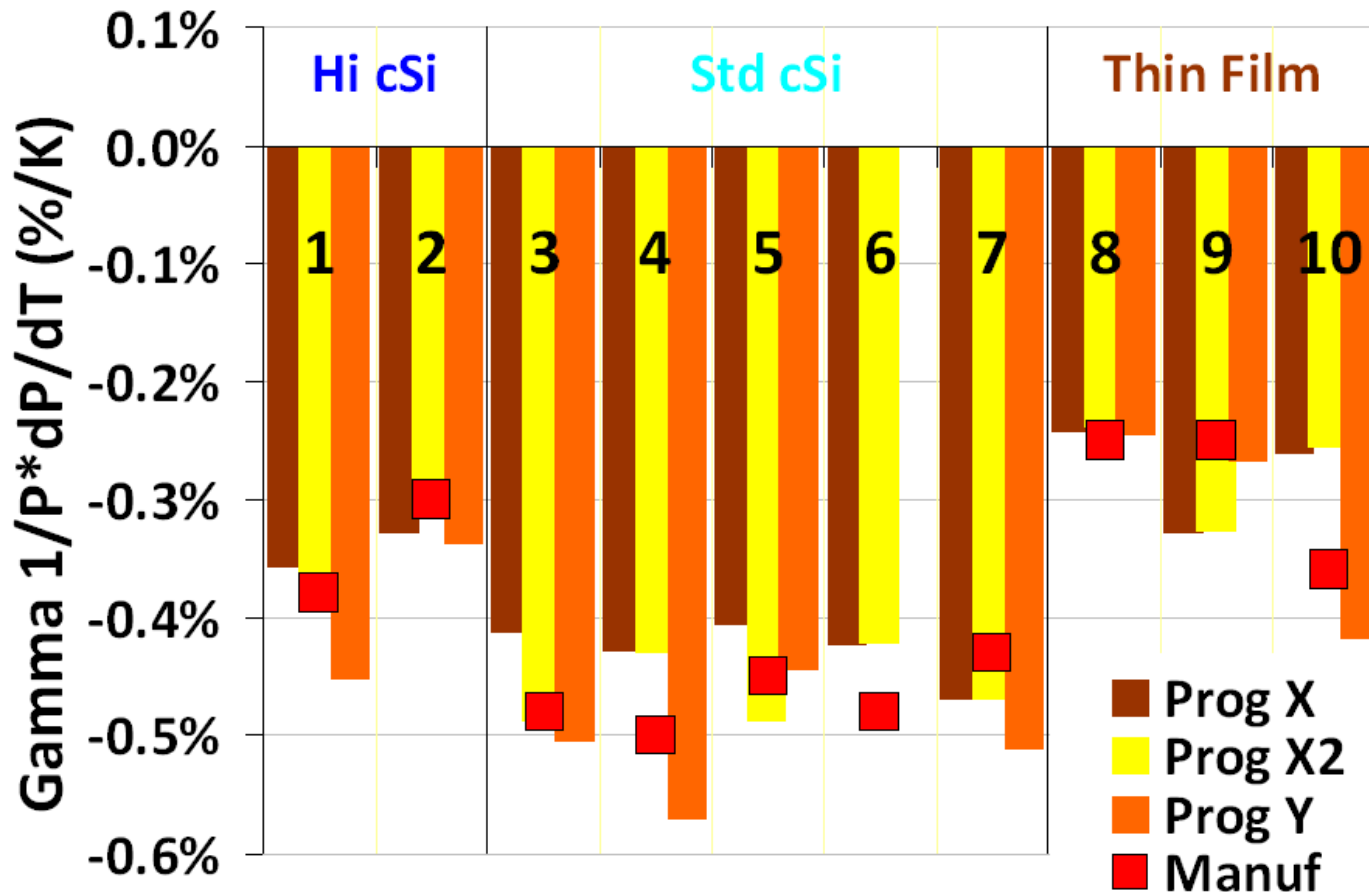
Simulation programs



Disagreement
between
program version
values

Comparing power temperature coefficients ($\text{Gamma} = 1/P_{\text{max}} * dP_{\text{max}}/dT$)

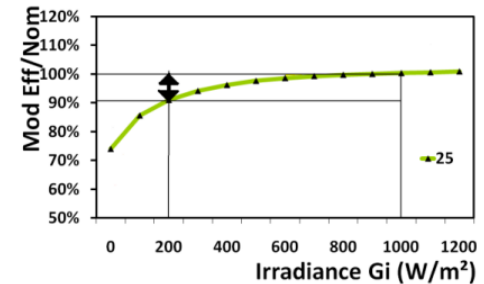
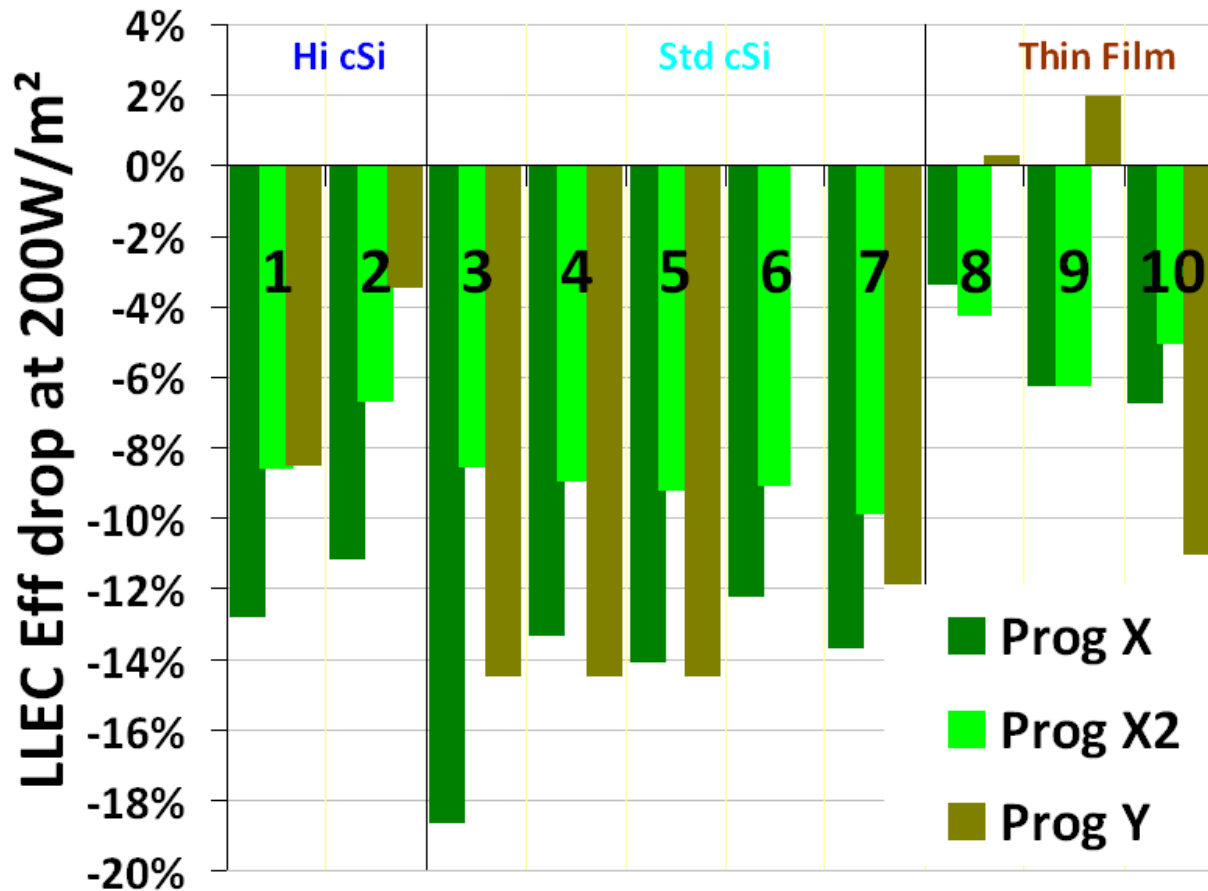
Simulation programs vs. **Manufacturer datasheet**



Also
disagreement
with
manufacturer
datasheet

Comparing Low Light efficiency changes (LLEC = $\text{Eff@200}/\text{Eff@1000}-1$)

Simulation programs

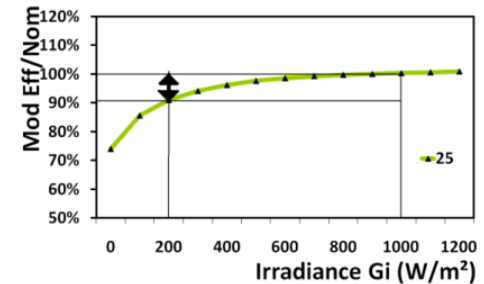
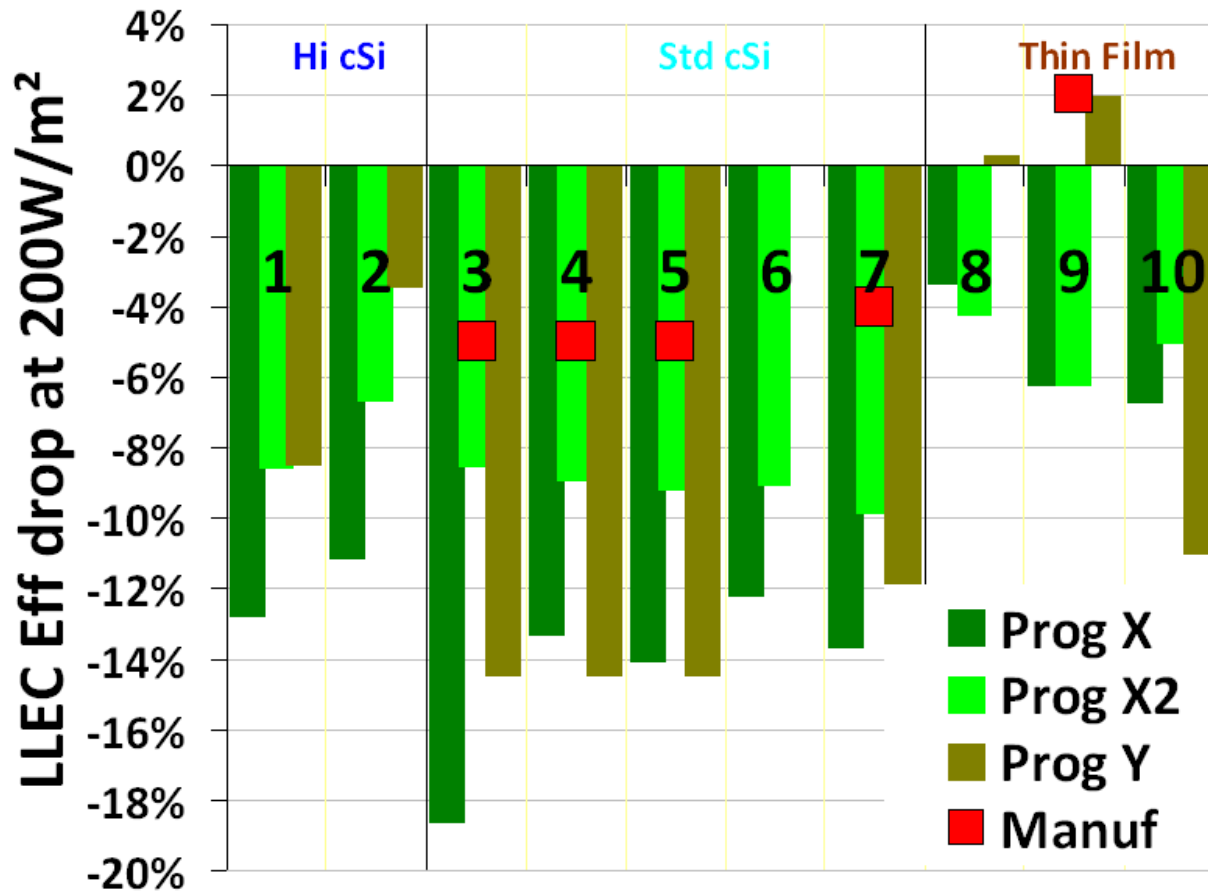


Disagreement
between
program version
values

Comparing Low Light efficiency changes (LLEC = $\text{Eff@200}/\text{Eff@1000}-1$)



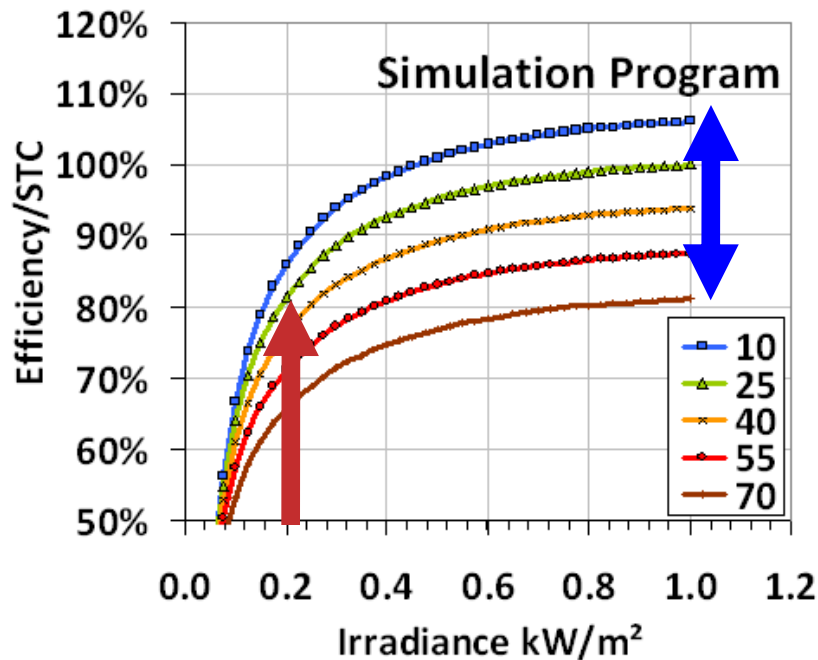
Simulation programs vs. **Manufacturer datasheet**



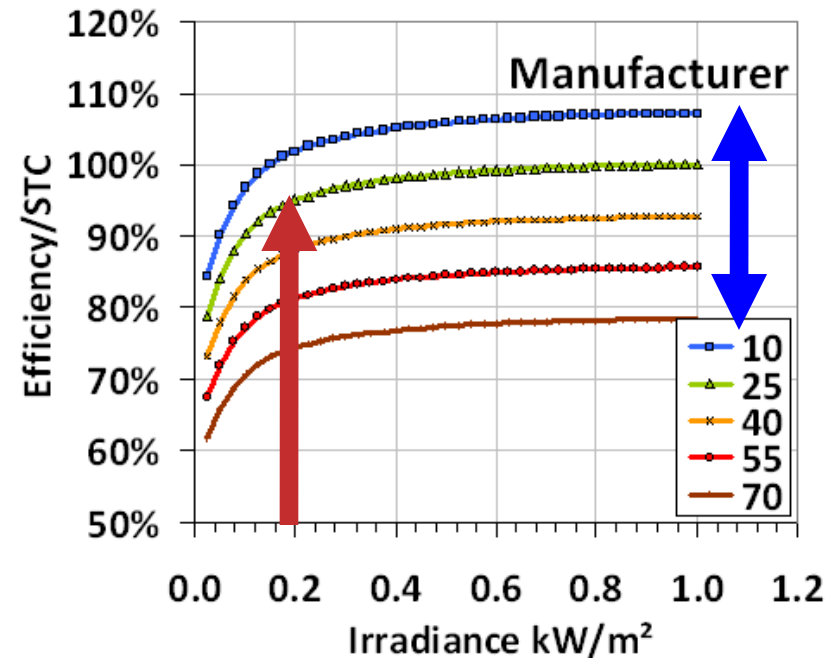
Also
disagreement
with
manufacturer
datasheet

Correcting simulation program efficiency to manufacturer's datasheet : c-Si #3

Gamma ($1/P_{max} * dP_{max}/dT$)
-0.42%/K $\rightarrow$ -0.48%/K



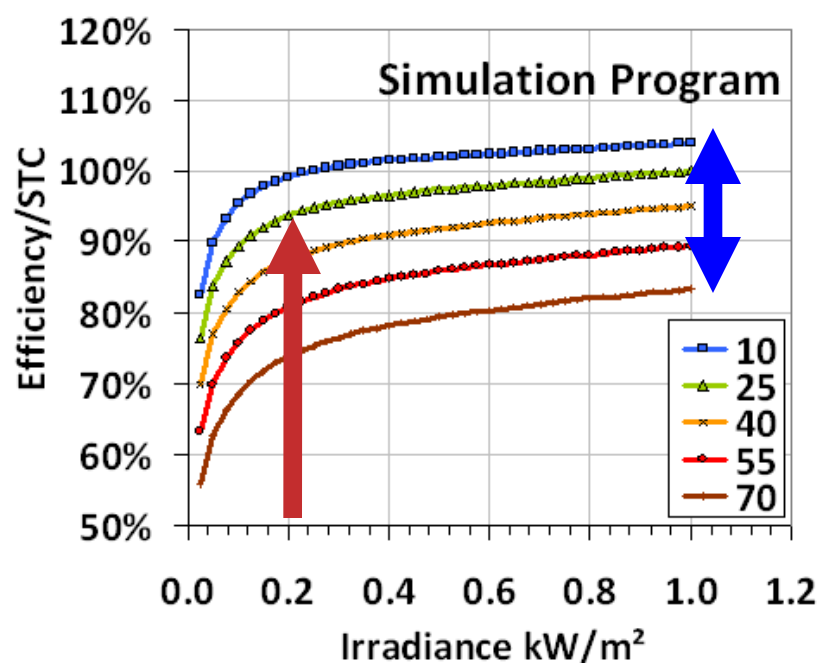
Low light efficiency change
82% $\rightarrow$ 95%



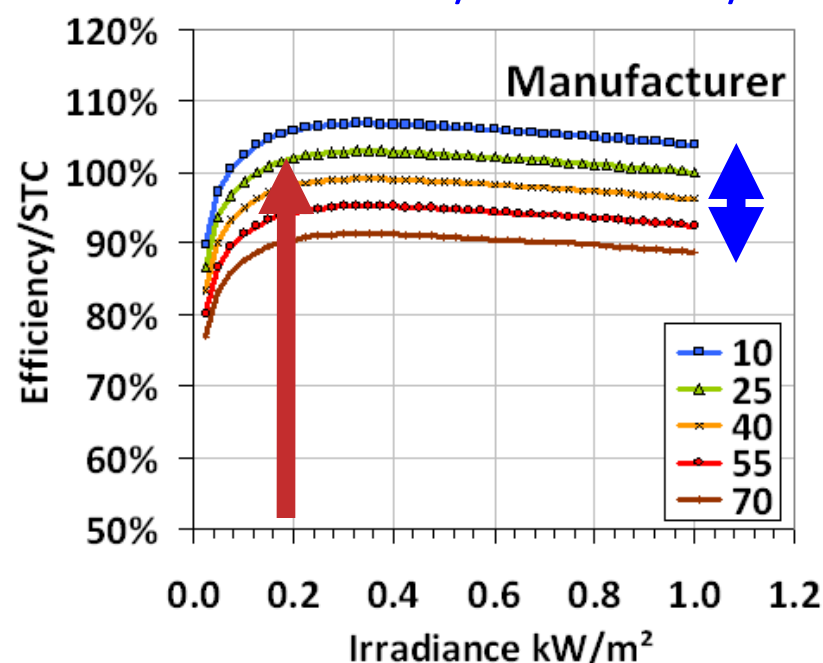
•High Rshunt gives high efficiency down to low light levels for c-Si

Correcting simulation program efficiency to manufacturer's datasheet : Thin film #9

Gamma (dPmax/dTemperature)
-0.32%/K $\rightarrow$ -0.25%/K



Low light efficiency change
94% $\rightarrow$ 102%



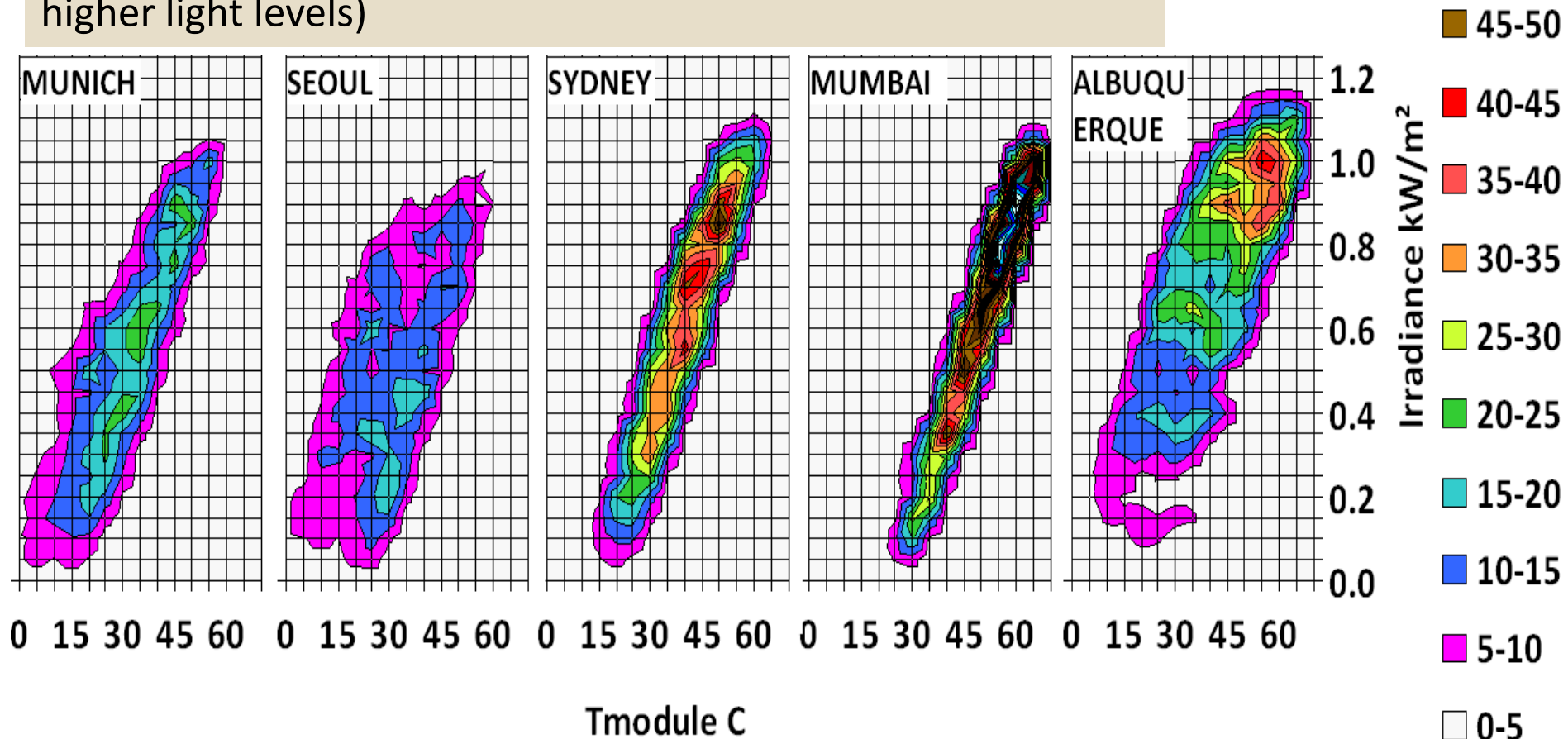
High Rseries causes efficiency to fall at high light levels due to I²R loss

Checking kWh/kWp simulation errors at 5 sites worldwide

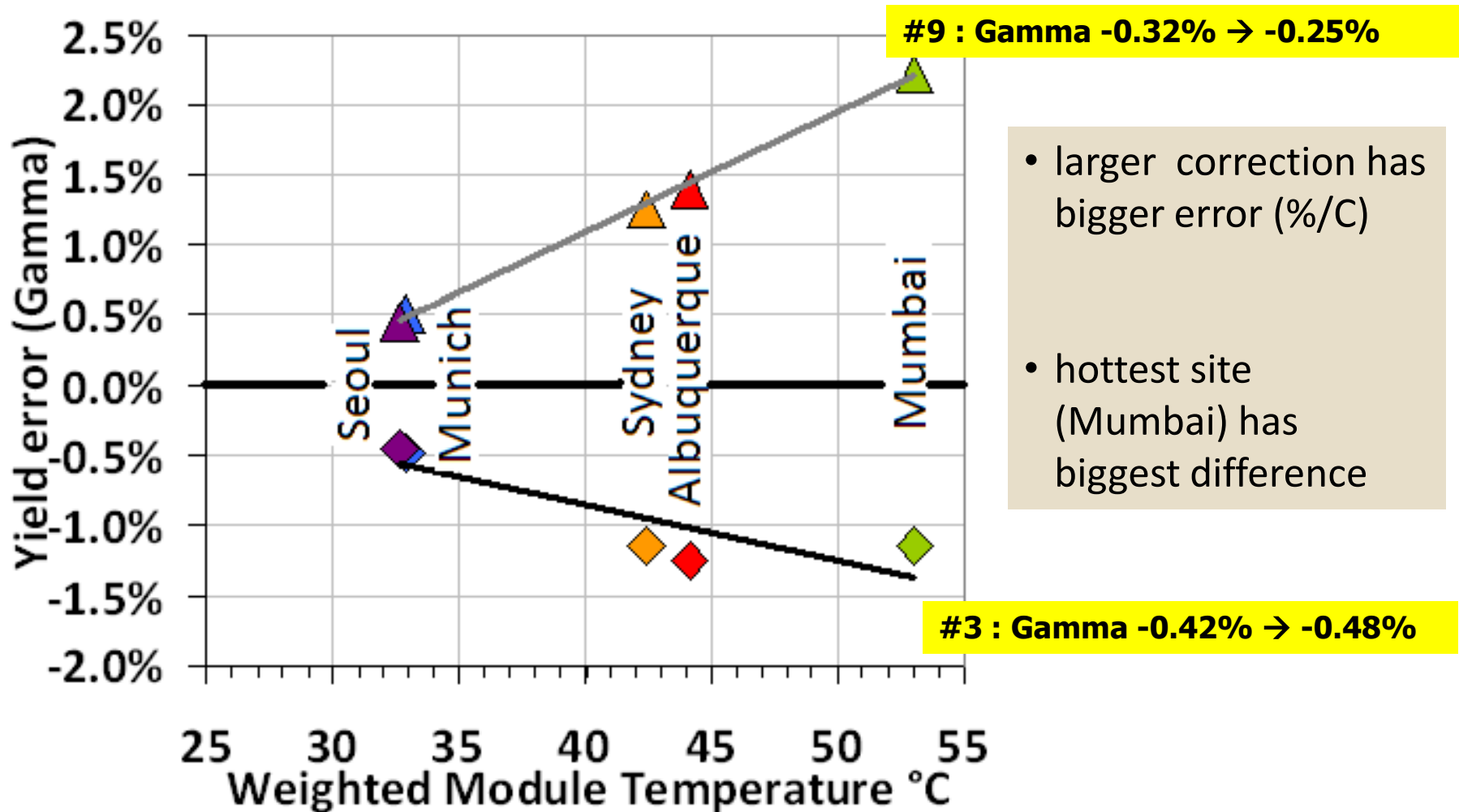
	Site name, Country	Latitude °	POA Insolation kWh/m ²	Weighted Tambient °C
	Insolation, temperature			
1	Munich, DE →Dull, cool	48°N	1345 *	14.3 *
2	Albuquerque NM, USA →Very bright, warm	35°N	2336 ***	18.7 **
3	Mumbai, IN →Bright, Hot	19°N	1988 **	30.3 ***
4	Seoul, KO →Dull, cool	38°N	1299 *	15.4 *
5	Sydney, AU →Bright, warm	34°S	1797 **	20.8 **

Modelled hourly insolation vs. irradiance and module temperature at 5 sites worldwide

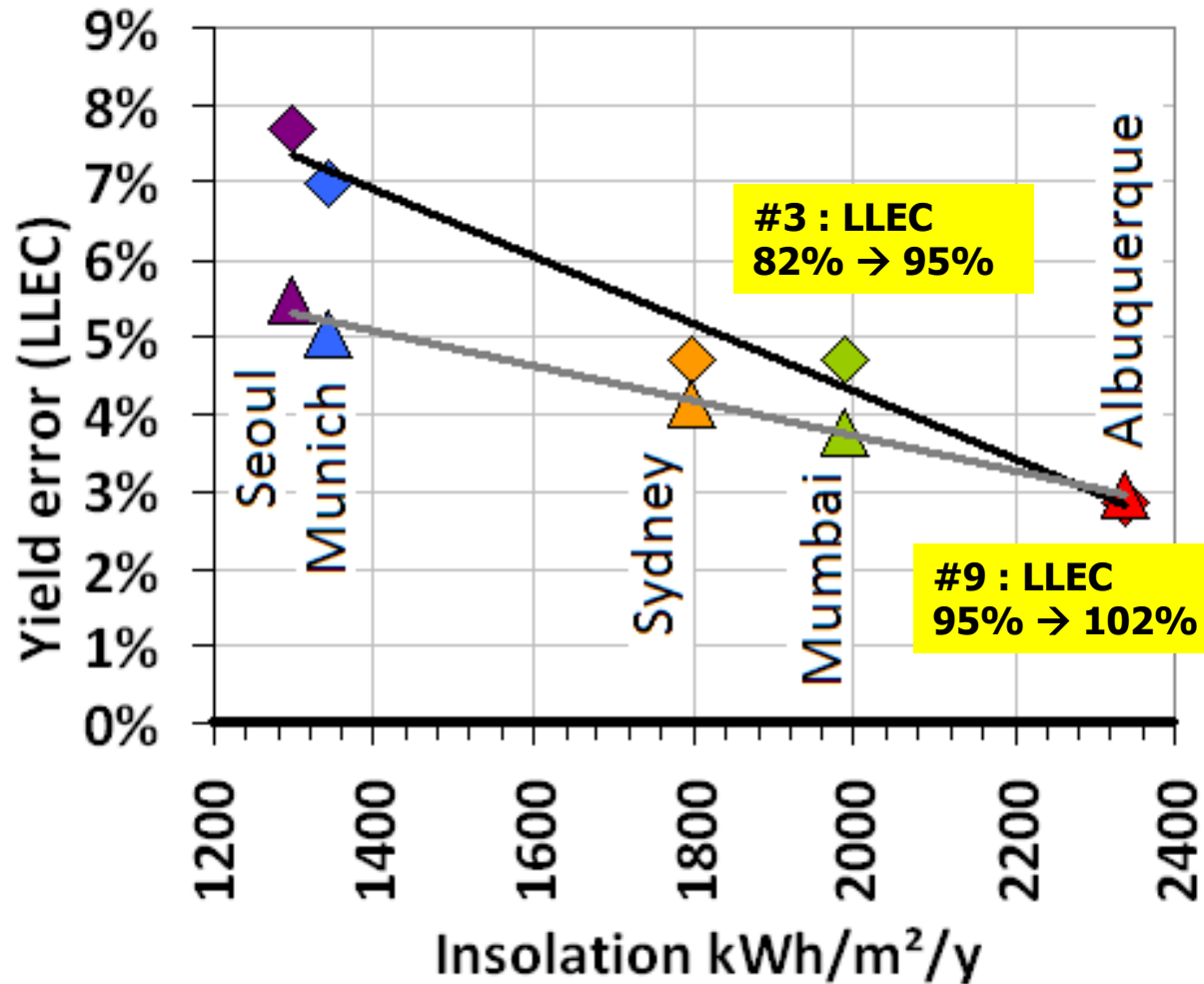
(more frequent measurements prove more insolation at higher light levels)



Simulation program modelled kWh/kWp vs. power temperature coefficient error



Simulation program modelled kWh/kWp vs. Low light efficiency change error



- larger correction has bigger error up to 8%
- Sunniest site has smallest difference

Measured kWh/kWp < $\sim \pm 5\%$ from several independent studies, dominated by [Wp.actual/Wp.nominal], not technology dependent

Simulation program kWh/kWp predictions

- dominated by errors in database values for “Efficiency at low light” and “Pmax vs. temperature”
- Efficiency at low light is modelled worse than manufacturers’ claims for both c-Si and thin film
- Correcting low light efficiency - biggest gain in cloudy conditions
- Correcting Pmax temp. coefficient - biggest change in hot conditions
- Corrections values vary by manufacturer and technology
- c-Si has been modelled more pessimistically than thin film
- These corrections should bring modelled kWh/kWp closer together by technology to match real measurements better



Acknowledgements : Oerlikon, IWES for data

Next conference : www.pvsat.org.uk

“The British Staffelstein”

Southampton, UK

24-26 March 2010



Thank you for your attention !

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